PTO/SB/08a (08-03)
Approved for use through 07/31/2008. OMB 0651-0031
U.S. Patent and Tredemark Office: U.S. DEPARTMENT OF COMMERCE
the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it contains a valid OMB control number.

TANDS VIET ate for form 1449A/PTO Complete if Known Application Number 10/809,867 INFORMATION DISCLOSURE March 26, 2004 Filing Date STATEMENT BY APPLICANT First Named Inventor Masanori UEDA et al. Form PTO/SB/08a Art Unit 3729 Anthony D. Tugbang **Examiner Name** 025720-00027 Attomey Docket Number of 1 1 Sheet

			U.S. P	ATENT DOCU	MENTS	
Examiner Initials*	Cite No.1	Document Number	Number-Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, When Relevant Passages or Relevant Flories Appear
		US-				
		US-				
		US-				
		US-				
	1	US-				
	1	US-				
<del></del>	1	US-				
	1	US-				
		US-				
		US-				
<del></del>		US				
		US-				
		US-				

			FOREIG	N PATENT DO	CUMENTS		
Cite No.1	Foreign Patent Document	Country Code <sup>3</sup>	Number Kind Code (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	Τ*
	2001-060846	JP	Α	03-06-2001	CO. LTD.		АВ
	9-008595	JP	Α	01-10-1997	MATSUSHITA ELECTRIC IND CO. LTD.		АВ
	2001-060658	JP	Α	03-06-2001	ROHM CO. LTD.		AB
	2001-332654	JP	Α	11-30-2001	MATSUSHITA ELECTRIC IND. CO. LTD.		АВ
	2003-068744	JP	Α	03-07-2003	SHINETSU HANDOTAI KK		AB
	2002-184960	JP	Α	06-28-2002	SHINETSU HANDOTAI KK		AB
Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.						L,
	Hideki TAKAGI, "Room-Temperature Bonding of Silicon Wafers by means of the Surface Activation Method" Report of Mechanical Engineering Laboratory No. 189, December 2000, Pages 1-7, and 68-84.						AB
	No.'	2001-060846  9-008595  2001-060658  2001-332654  2003-068744  2002-184960  Cite Include name of the authorities at a long etc.), date, page	2001-060846	Cite No.   Foreign Patent Document   Country Code   (if known)	Cite No.   Foreign Patent Document   Country Code   Mind Code   MM-DD-YYYY	Cite No.¹ Foreign Patent Document Code³ (If known) MM-DD-YYYY Cited Document Cite	Foreign Patent Document   Country   Code <sup>3</sup>   Publication Date   MM-DD-YYYY   Name of Patentee or Applicant of Cited Document   Country   Code <sup>3</sup>   Publication Date   MM-DD-YYYY   MATSUSHITA ELECTRIC IND   CO. LTD.

		Date	l
Examiner	/a Santan Marchany	Date	5/24/07
	/A. Dexter Tugbang/	Considered	] 3/24/0/
Signature	,	CONSIDERE	

<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. \*Unique citation designation number. \*See attached Kinds of U.S. Patent Documents. \*Enter Office that issued the document, by the two-letter code. \*For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. \*Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. \*Applicant is to place a check mark here if English language translation is attached. AB indicates that only an English language abstract is attached.